Search Notes (continued)

Application/Control No.	Applicant(s)/Patent under Reexamination
10/823,020	YAMAZAKI ET AL.
Examiner	Art Unit

James Phan

2872

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
,	DATE	EXMR		
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